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| Notice of References Cited | Application/Control No. 10/615,894 | | Applicant(s)/Patent Under Reexamination OOTSUKA, TAKESHI | |
| | Examiner Rakesh K. Dhingra | | Art Unit 1763 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-2005/0051100 | 03-2005 | Chiang et al. | 118/728 |
| * | B | US-5,591,269 | 01-1997 | Arami et al. | 118/723R |
| * | C | US-6,645,304 | 11-2003 | Yamaguchi, Shinji | 118/725 |
| * | D | US-6,693,789 | 02-2004 | Inazumachi et al. | 361/234 |
| * | E | US-6,475,924 | 11-2002 | Yamamoto et al. | 438/758 |
| * | F | US-6,486,542 | 11-2002 | Ohashi et al. | 257/684 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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